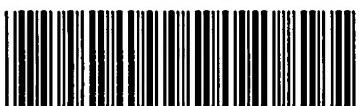


Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10680930	CHATTERJEE ET AL.
	Examiner	Art Unit
	Nguyen, Kevin M	2629

SEARCHED

Class	Subclass	Date	Examiner
345	1.1-1.3,2.1-2.3,3.1-3.4 (updated 5/1/2007)	11/22/2006	KMN
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SEARCH NOTES

Search Notes	Date	Examiner
Text and keyword searched (see EAST notes)	11/22/2006	KMN
Inventor's names searched		

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner